IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

XPPLICANTS:

Martin HOHEISEL et al.

CONF. NO.: 5214

**SERIAL NO.:** 

10/655.025

GROUP: 2882

FILED:

September 5, 2003

EXAMINER: Allen C. Ho

FOR:

METHOD FOR PRODUCING AND APPLYING AN

ANTISCATTER GRID OR COLLIMATOR TO AN X-RAY OR

GAMMA DETECTOR

## COMMENTS ON EXAMINER'S STATEMENT OF REASONS FOR ALLOWANCE

Customer Service Window Randolph Building 401 Dulany Street Alexandria, VA 22314 Mail Stop Issue Fee November 3, 2006

## Dear Sir:

The Examiner offers reasons why the claims of the present application are allowable over the prior art of record. Although Applicants agree that the various claimed limitations mentioned in the claims are not taught or suggested by the prior art taken either singly or in combination, Applicants wish to emphasize that it is the language of each claim taken individually, including the interrelationships and interconnections between various claimed elements, which is allowable over the prior art of record.

For example, with regard to claim 1, the Examiner emphasizes that the prior art fails to teach or fairly suggest a basic structure produced by layer-wise solidification by using a rapid prototyping technique. *Notice of Allowance*, p. 2. Applicants agree that

this feature is not taught or fairly suggested by the prior art; however, Applicants wish to emphasize that it may be this feature alone and/or in combination with all other features of claim 1 that distinguishes claim 1 over the prior art of record.

Similar reasoning applies to each of claims 2-34.

Respectfully submitted,

HARNESS, DICKEY & PIERCE, PLC

Βv

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